ROBOTIC TEST SYSTEMS TRACKER 5100DS

Harness the efficiency of digital storage

- Windows or DOS-based interface for ease of use
- Computer "learns" and stores component "signatures" for later comparison and testing
- Virtually unlimited digital storage means you always have signature data on hand



Connected to a PC, the Tracker 5100DS offers digital storage, so you don't forget what a signature looks like. You can share data with other technicians equipped with Huntron tools, for extremely efficient repair facility operations. The 5100DS digitizes the analog signature, and the computer reads, compares and stores the information. Once you've learned a known-good board there is no need to keep it on hand. The 5100DS gives you the flexibility to economically create test routines for low volumes and wide varieties of circuit boards.

SPECIFICATIONS Test Signal

Waveform	Sine Wave (normal mode) Triangle Wave (for calibration/maintenance only)
Frequency	200 Hz ±1 Hz

Unless otherwise noted, these specifications apply over the operating temperature range of +15° C to +30° C.

Open Circuit Voltage

Range	Nominal ¹	Triangle Wave ²	Sine Wave ²	
High Medium 2 Medium 1 Low	60 Volts peak 20 Volts peak 15 Volts peak 10 Volts peak	34.32 Volts RMS 11.49 Volts RMS 8.64 Volts RMS 5.76 Volts RMS	42.04 Volts RMS 14.08 Volts RMS 10.59 Volts RMS 7.06 Volts RMS	

The peak voltage is the same for both waveforms. The nominal data represents design values with an open circuit on the front panel TEST jack.

² These RMS voltages take into account the load on the TEST jack caused by a digital multimeter with $10M\Omega$ input impedance.

Short Circuit Current

Range		Triangle Wave	Sine Wave
	High	0.465 mA RMS	0.570 mA RMS
	Medium 2	0.432 mA RMS	0.529 mA RMS
	Medium 1	6.96 mA RMS	8.54 mA RMS
	Low	108.8 mA RMS	132.3 mA RMS

General Specifications

Overload Protection	Signal Fuse	¼-Amp AGC Protects TEST Line	
(front panel replaceable)	Common Fuse	1-Amp AGC Protects COMMON Line	
Discrete Components	TEST and COMMON front panel jacks provided for use with probes		
Multiple Pin Devices	Test Pins Common Pins	64 (maximum) 64 (maximum)	
Display	Type Size Acceleration Potential	Monochrome CRT 2.8 in (7.0 cm) diagonal 1200 V DC ±20 V DC (regulated)	
Test Connectors	64-, 40- and 20- pin IDC connectors (for DIP clip cables) 40-pin ZIF socket (for individual component testing)		
Interface	GPIB (IEEE-488)		
Dimensions	20.3 in L x 12.0 in W x 6.3 in H (51 cm L x 31 cm W x 16 cm H)		
Weight	16.5 lb (7.5 kg)		
Operating Temperature	+59° F to +86° F (+1	5° C to +30° C)	
Storage Temperature	-58° F to +140° F (-50° C to +60° C)		

Note: All values are $\pm 1\%$, except Low range $\pm 5\%$.

Ordering Information